Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/517,355	MOK, KENNETH HUN	
Examiner	Art Unit	
David Lukton	1654	

	SEARCHED						
Class	Subclass	Date	Examiner				
514	18	1/10/06	DL				
530	331	V	V				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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